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### (54) DIAGNOSIS MODEL GENERATION SYSTEM AND METHOD

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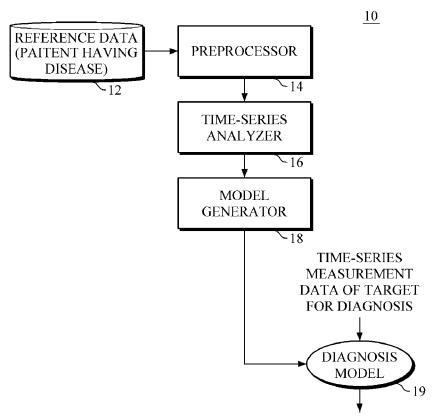
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#### (57)**ABSTRACT**

A system to generate a diagnosis model includes: a preprocessor configured to preprocess time-series data observed from a patient having a disease; a time-series analyzer configured to produce a data feature by applying an analysis model for a time-series variability analysis to the preprocessed time-series data; and a model generator configured to extract the produced data feature and to generate the diagnosis model based on the extracted produced data feature.



CHANGED CONDITION OF DISEASE ESTIMATE RISK OF DISEASE OCCURRENCE